

Notice of References Cited	Application/Control No. 10/796,370		Applicant(s)/Patent Under Reexamination SHAVER ET AL.	
	Examiner Christopher B. Shin		Art Unit 2181	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,590,587	07-2003	Wichelman et al.	715/736
*	B	US-7,043,646	05-2006	Enami et al.	713/300
*	C	US-6,229,538	05-2001	McIntyre et al.	715/734
*	D	US-5,675,814	10-1997	Pearce, John J.	713/324
*	E	US-6,657,534	12-2003	Beer et al.	340/3.1
*	F	US-6,567,921	05-2003	Guziak, James Edward	713/322
*	G	US-2005/0144498	06-2005	Lin, Chia-Lung	713/600
*	H	US-2004/0230846	11-2004	Mancey et al.	713/300
*	I	US-2003/0191886	10-2003	Teshima et al.	711/100
*	J	US-2002/0089806	07-2002	Hamilton et al.	361/227
*	K	US-6,061,800	05-2000	Chiu, Hung-Che	713/300
*	L	US-2006/0093102	05-2006	McElvaney, David	379/088.17
*	M	US-5,664,123	09-1997	Lee et al.	710/62

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.